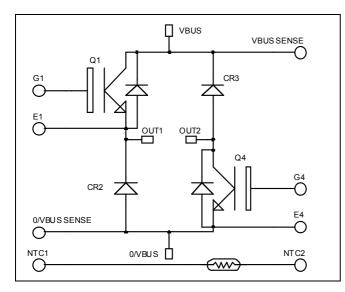


Asymmetrical - Bridge NPT IGBT Power Module



U VBUS \mathbf{O} 0 G4 🕯 OUT2 SENSE E4 🛿 VBUS 0/VBUS OUTI E1 0/VBUS NTC2 \bigcirc SENSE D NTC1 0 Ğı

Absolute maximum ratings

Symbol	Parameter		Max ratings	Unit
V _{CES}	Collector - Emitter Breakdown Voltage		1200	V
т	Continuous Collector Current	$T_c = 25^{\circ}C$	75	
I _C	Continuous Conector Current	$T_c = 80^{\circ}C$	50	А
I _{CM}	Pulsed Collector Current	$T_c = 25^{\circ}C$	150	
V _{GE}	Gate – Emitter Voltage		±20	V
PD	Maximum Power Dissipation	$T_c = 25^{\circ}C$	312	W
RBSOA	Reverse Bias Safe Operating Area	$T_{j} = 150^{\circ}C$	100A @ 1200V	
	* *		Ö	

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

$V_{CES} = 1200V$ $I_{C} = 50A$ (a) $Tc = 80^{\circ}C$

Application

- Welding converters
- Switched Mode Power Supplies
- Switched Reluctance Motor Drives

Features

- Non Punch Through (NPT) Fast IGBT
 - Low voltage drop
 - Low tail current
 - Switching frequency up to 50 kHz
 - Soft recovery parallel diodes
 - Low diode VF
 - Low leakage current
 - RBSOA and SCSOA rated
- Kelvin emitter for easy drive
- Very low stray inductance
 - Symmetrical design
 - Lead frames for power connections
- Internal thermistor for temperature monitoring
- High level of integration

Benefits

- Outstanding performance at high frequency operation
- Stable temperature behavior
- Very rugged
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Easy paralleling due to positive T_C of V_{CEsat}
- Low profile
- RoHS compliant

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All ratings (a) $T_j = 25^{\circ}C$ unless otherwise specified

Electrical Characteristics

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit	
т	Zero Gate Voltage Collector Current	$V_{GE} = 0V$	$T_i = 25^{\circ}C$			250	μA
I _{CES}	Zero Gate Voltage Collector Current	$V_{CE} = 1200V$	$T_{i} = 125^{\circ}C$			500	μΑ
V	Callester Engitter externation Valtered	$V_{GE} = 15V$	$T_j = 25^{\circ}C$		3.2	3.7	N/
V _{CE(sat)}	Collector Emitter saturation Voltage	$I_C = 50A$	$T_{j} = 125^{\circ}C$		4.0		v
V _{GE(th)}	Gate Threshold Voltage	$V_{GE} = V_{CE}$, $I_C = 1 \text{ mA}$		4.5		6.5	V
I _{GES}	Gate – Emitter Leakage Current	$V_{GE} = 20 V, V_{CE}$	$V_{GE} = 20 V, V_{CE} = 0V$			100	nA

Dynamic Characteristics

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
Cies	Input Capacitance	$V_{GE} = 0V$ $V_{CE} = 25V$			3450		
C _{oes}	Output Capacitance				330		pF
C _{res}	Reverse Transfer Capacitance	f = 1 MHz			220		
Qg	Total gate Charge	$V_{GS} = 15V$			330		
Q _{ge}	Gate – Emitter Charge	$V_{Bus} = 600V$			35		nC
Q _{gc}	Gate – Collector Charge	$I_{\rm C} = 50 {\rm A}$			200		
T _{d(on)}	Turn-on Delay Time	Inductive Switching (25°C)			35		
Tr	Rise Time	$V_{GE} = 15V$			65		
T _{d(off)}	Turn-off Delay Time	$V_{Bus} = 600V$ $I_C = 50A$ $R_G = 5 \Omega$			320		ns
T _f	Fall Time				30		
T _{d(on)}	Turn-on Delay Time	Inductive Switching (125°C) $V_{GE} = \pm 15V$ $V_{Bus} = 600V$ $I_C = 50A$ $R_G = 5 \Omega$			35		
T _r	Rise Time				65		
T _{d(off)}	Turn-off Delay Time				360		ns
T _f	Fall Time				40		
Eon	Turn-on Switching Energy	$V_{GE} = \pm 15V$ $V_{Bus} = 600V$	$\Gamma_{\rm j} = 125^{\circ}{\rm C}$		6.9		mI
E _{off}	Turn-off Switching Energy	$I_{C} = 50A$ $R_{G} = 5 \Omega$	$\Gamma_{\rm j} = 125^{\circ}{\rm C}$		3.05		mJ

Diode ratings and characteristics

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
V _{RRM}	Maximum Peak Repetitive Reverse Voltage			1200			V
I _{RM}	Maximum Reverse Leakage Current	V _R =1200V	$T_{j} = 25^{\circ}C$ $T_{i} = 125^{\circ}C$			250 500	μΑ
I _F	DC Forward Current		$Tc = 70^{\circ}C$		100		А
		$I_{\rm F} = 100 {\rm A}$			2.0	2.5	
$V_{\rm F}$	Diode Forward Voltage	$I_{\rm F} = 200 {\rm A}$			2.3		V
		$I_{\rm F} = 100 {\rm A}$	$T_{j} = 125^{\circ}C$		1.8		
t	Reverse Recovery Time	$I_{\rm F} = 100 \text{A}$ $V_{\rm R} = 800 \text{V}$	$T_j = 25^{\circ}C$		420		ns
t _{rr}			$T_{j} = 125^{\circ}C$		580		115
Q _{rr}	Reverse Recovery Charge	$di/dt = 200 A/\mu s$	$T_j = 25^{\circ}C$		1250		nC
Vrr			$T_{j} = 125^{\circ}C$		5350		ne



Thermal and package characteristics

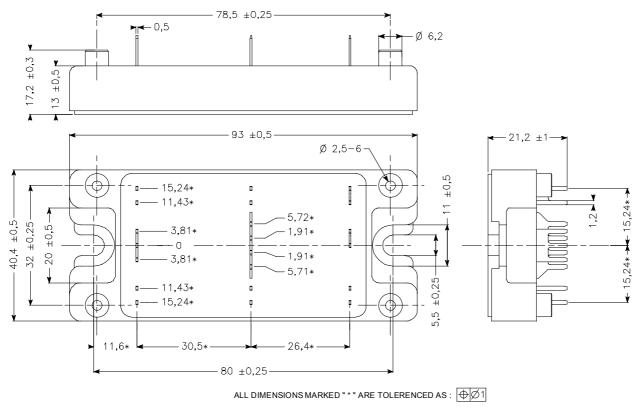
Symbol	Characteristic			Min	Тур	Max	Unit
R _{thJC}	Junction to Case Thermal Resistance		IGBT			0.4	°C/W
R _{th} JC			Diode			0.55	C/ w
V _{ISOL}	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz		4000			V	
T _J	Operating junction temperature range			-40		150	
T _{STG}	Storage Temperature Range		-40		125	°C	
T _C	Operating Case Temperature			-40		100	
Torque	Mounting torque	To Heatsink	M5	2.5		4.7	N.m
Wt	Package Weight					160	g

Temperature sensor NTC (see application note APT0406 on www.microsemi.com for more information).

Symbol	Characteristic	Min	Тур	Max	Unit
R ₂₅	Resistance @ 25°C		50		kΩ
B 25/85	$T_{25} = 298.15 \text{ K}$		3952		K

$$R_{T} = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$$
 T: Thermistor temperature
R_T: Thermistor value at T

SP4 Package outline (dimensions in mm)



See application note APT0501 - Mounting Instructions for SP4 Power Modules on www.microsemi.com



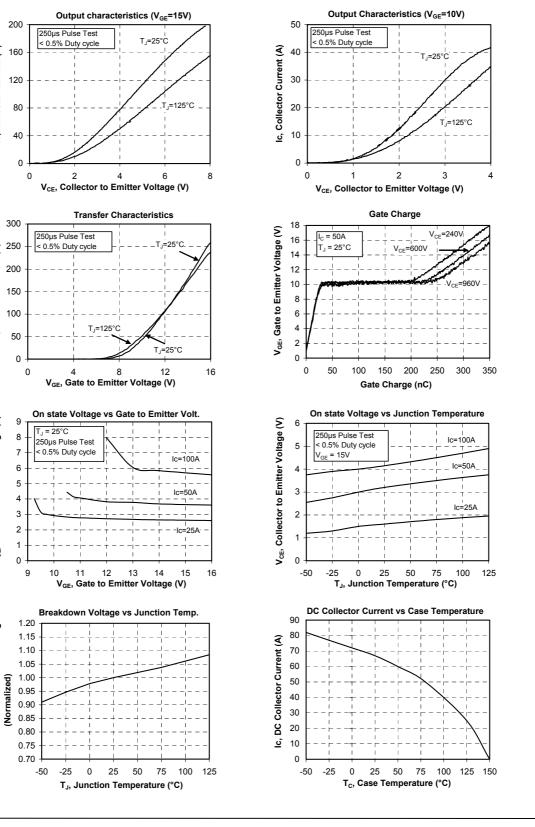
Typical Performance Curve

Ic, Collector Current (A)

Ic, Collector Current (A)

V_{CE}, Collector to Emitter Voltage (V)

Collector to Emitter Breakdown Voltage



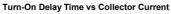
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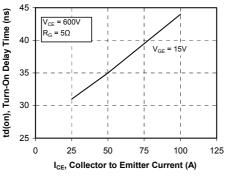
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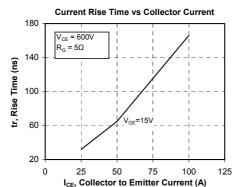
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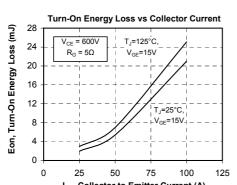
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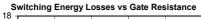


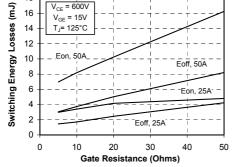




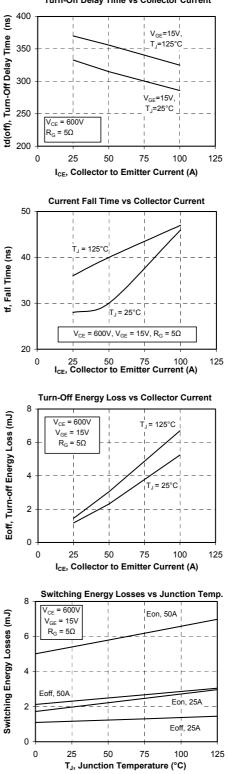






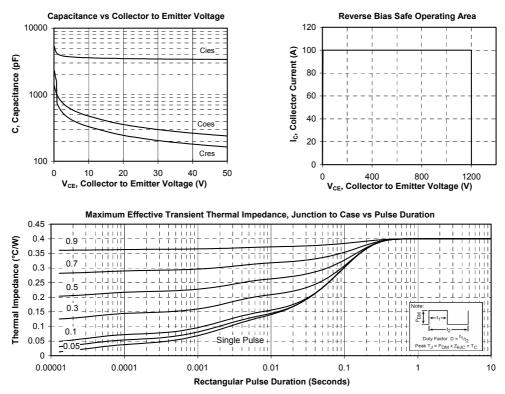


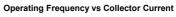
Turn-Off Delay Time vs Collector Current

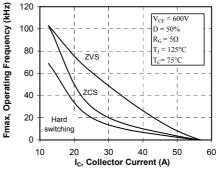


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